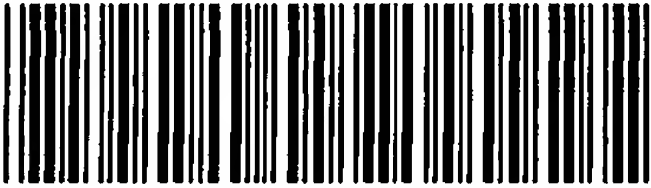


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/647,240	ICHIMURA, GEN	
	Examiner	Art Unit	
	Hanh Nguyen	2616	

SEARCHED			
Class	Subclass	Date	Examiner
360	60	5/11/2007	HN
386	94		
369	58		
380	4		
369	54		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east	5/11/2007	HN